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January 2015

FDMS86255ET150

N-Channel Shielded Gate PowerTrench[®] MOSFET 150 V, 63 A, 12.4 m Ω

Features

- Extended T_J rating to 175°C
- Shielded Gate MOSFET Technology
- Max $r_{DS(on)} = 12.4 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 10 \text{ A}$
- Max $r_{DS(on)} = 15.5 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 8 \text{ A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

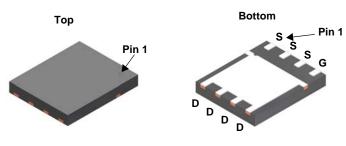


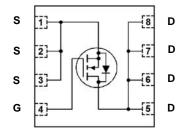
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

Applications

- OringFET / Load Switching
- Synchronous rectification
- DC-DC Conversion





Power 56

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol		Parame	ter		Ratings	Units
V _{DS}	Drain to Source Voltage				150	V
V _{GS}	Gate to Source Vo	oltage			±20	V
	Drain Current	-Continuous	T _C = 25 °C	(Note 5)	63	
		-Continuous	T _C = 100°C	(Note 5)	44	Α
ID		-Continuous	T _A = 25 °C	(Note 1a)	10	A
		-Pulsed		(Note 4)	276	
E _{AS}	Single Pulse Avala	anche Energy		(Note 3)	541	mJ
D	Power Dissipation		T _C = 25 °C		136	W
P_{D}	Power Dissipation	1	T _A = 25 °C	(Note 1a)	3.3	VV
T _{.I} , T _{STG}	Operating and Sto	rage Junction Temperat	ure Range		-55 to +175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	45	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86255ET	FDMS86255ET150	Power 56	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		109		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V			1	μА
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	3.0	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-11		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 10 A		9.5	12.4	
		$V_{GS} = 6 \text{ V}, I_D = 8 \text{ A}$		11.5	15.5	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}, T_J = 125 \text{ °C}$		19	25	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 10 A		35		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 75.V.V 0.V		3200	4480	pF
C _{oss}	Output Capacitance	V _{DS} = 75 V, V _{GS} = 0 V, f = 1 MHz		291	410	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12		11	20	pF
R _q	Gate Resistance		0.1	0.7	2.1	Ω

Switching Characteristics

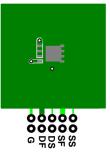
t _{d(on)}	Turn-On Delay Time				21	34	ns
t _r	Rise Time	V _{DD} = 75 V, I _D = 10	$V_{DD} = 75 \text{ V}, I_{D} = 10 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		4.5	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN}$			28	45	ns
t _f	Fall Time				6.2	12	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V			45	63	nC
Q_{g}	Total Gate Charge	$V_{GS} = 0 \text{ V to 6 V}$	V _{DD} = 75 V,		29	41	nC
Q _{gs}	Gate to Source Charge		I _D = 10 A		14		nC
Q_{gd}	Gate to Drain "Miller" Charge				8.8		nC

Drain-Source Diode Characteristics

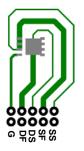
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 1.9 \text{ A}$ (Note	2)	0.7	1.2	\/
		$V_{GS} = 0 V, I_{S} = 10 A$ (Note	2)	0.8	1.3	v
t _{rr}	Reverse Recovery Time	I _F = 10 A, di/dt = 100 A/μs		87	139	ns
Q _{rr}	Reverse Recovery Charge	-1 _F = 10 A, αl/αl = 100 A/μs		165	264	nC

Notes:

1. R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0CA} is determined by the user's board design.



a. 45 °C/W when mounted on a
 1 in² pad of 2 oz copper.



 b. 115 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.
- 3. E_{AS} of 541 mJ is based on starting $T_{J} = 25$ °C, L = 3 mH, $I_{AS} = 19$ A, $V_{DD} = 150$ V, $V_{GS} = 10$ V. 100% tested at L = 0.1 mH, $I_{AS} = 60$ A.
- 4. Pulse Id please refer to Fig.11 SOA curve for detail.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics T_J = 25 °C unless otherwise noted

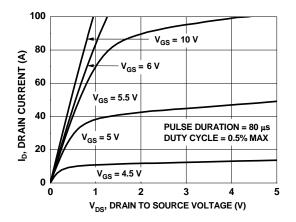


Figure 1. On-Region Characteristics

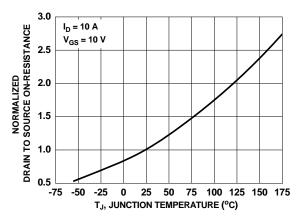


Figure 3. Normalized On-Resistance vs Junction Temperature

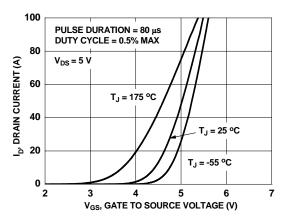


Figure 5. Transfer Characteristics

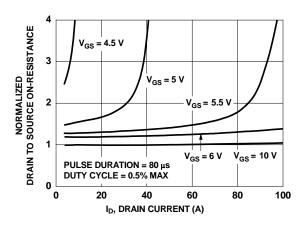


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

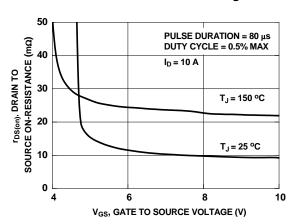


Figure 4. On-Resistance vs Gate to Source Voltage

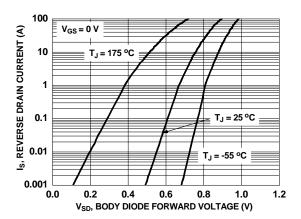


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

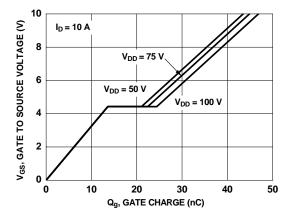


Figure 7. Gate Charge Characteristics

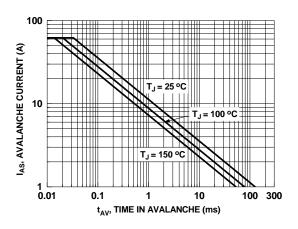


Figure 9. Unclamped Inductive Switching Capability

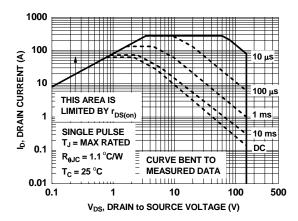


Figure 11. Forward Bias Safe Operating Area

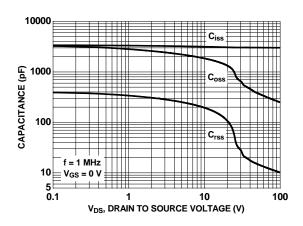


Figure 8. Capacitance vs Drain to Source Voltage

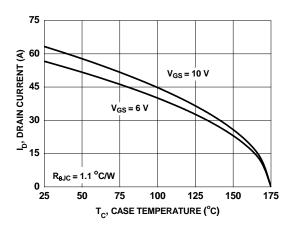


Figure 10. Maximum Continuous Drain Current vs Case Temperature

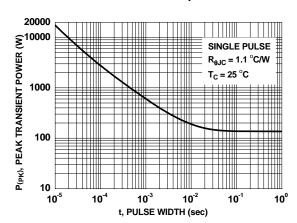


Figure 12. Single Pulse Maximum Power Dissipation



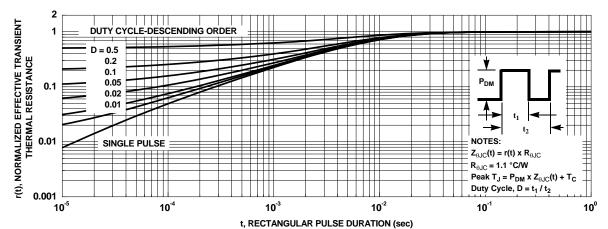
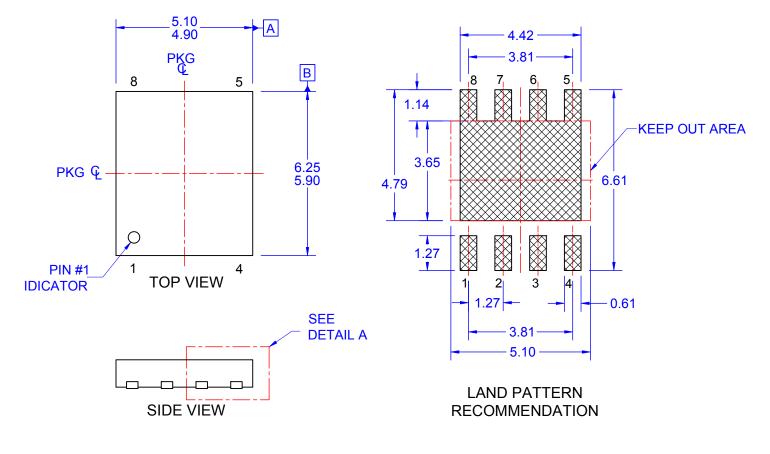
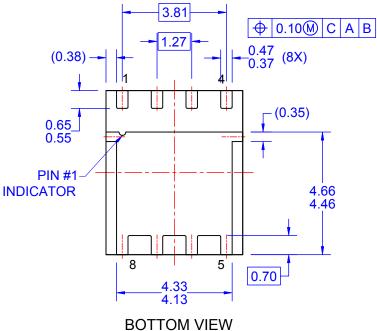
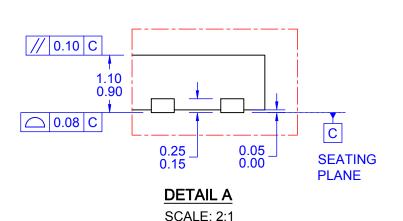


Figure 13. Transient Thermal Response Curve







NOTES: UNLESS OTHERWISE SPECIFIED

- A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA,
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- E) IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
- F) DRAWING FILE NAME: PQFN08JREV3.



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